

<b>Search Notes</b>	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/543,171	RENAUDIN ET AL.
Examiner	Art Unit	
Hae M. Hyeon	2839	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
439	801	3/01	hawh	
439	810			
65	496			